

**Search Notes**

Application/Control No.

10/689,499

Examiner

Y. J. Han

Applicant(s)/Patent under  
Reexamination

BAARMAN, DAVID W.

Art Unit

2838

**SEARCHED**

Class	Subclass	Date	Examiner
363	16		
	21.01		
	39		
	40		
	41		
	97		
	131		
see search report		12/05	JA

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR